

FDG6332C_F085

20V N & P-Channel PowerTrench[®] MOSFETs

Features

- Q1 0.7 A, 20V. $R_{DS(ON)} = 300 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$ $R_{DS(ON)} = 400 \text{ m}\Omega @ V_{GS} = 2.5 \text{ V}$
- Q2 -0.6 A, -20V. $R_{DS(ON)} = 420 \text{ m}\Omega @ V_{GS} = -4.5 \text{ V}$ $R_{DS(ON)} = 630 \text{ m}\Omega @ V_{GS} = -2.5 \text{ V}$
- Low gate charge
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- SC70-6 package: small footprint (51% smaller than SSOT-6); low profile (1mm thick)
- Qualified to AEC Q101
- RoHS Compliant



General Description

The N & P-Channel MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

These devices have been designed to offer exceptional power dissipation in a very small footprint for applications where the bigger more expensive TSSOP-8 and SSOP-6 packages are impractical.

Applications

- DC/DC converter
- Load switch
- LCD display inverter

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Complementary

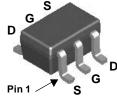
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FDG6332C_F085 20V N & P-Channel PowerTrench MOSFETs



SC70-6



Absolu			=25 C unless otherwise holed	1		
Symbol		Parameter	Q1	Q2	Unit	
V _{DSS}	Drain-Sour	ce Voltage		20	-20	V
V _{GSS}	Gate-Source	ce Voltage		±12	±12	V
ID	Drain Curre	ent – Continuous	(Note 1)	0.7	-0.6	А
		 Pulsed 		2.1	-2	
PD	Power Diss	sipation for Single Operation	tion (Note 1)	0	.3	W
T _J , T _{STG}	Operating a	and Storage Junction Te	mperature Range	–55 to	o +150	°C
Therma	l Charac	teristics				
$R_{\theta JA}$	Thermal Re	esistance, Junction-to-Ar	mbient (Note 1)	4	15	°C/W
Packag	e Markin	g and Ordering	Information			
Device	Marking	Device	Reel Size	Tape wi	dth	Quantity
.3	32	FDG6332C_F085	7"	8mm		3000 units

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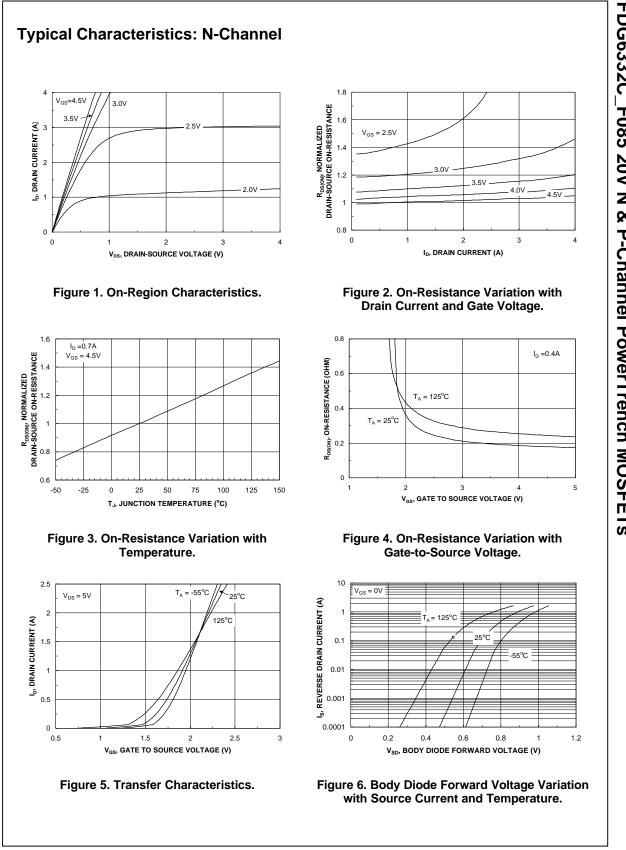
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Symbol	Parameter		Test Conditions	Min	Тур	Max	Units	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Off Char	acteristics							
	BVDSS	Drain-Source Breakdown Volta	ae			-			V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $		Breakdown Voltage Temperature				-20	14		mV/°C
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$		o 1		$I_D = -250 \ \mu$ A,Ref. to 25° C	Q2				
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	I _{DSS}	Zero Gate Voltage Drain Currer	nt						μA
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	I _{GSSF} /I _{GSSR}	Gate-Body Leakage, Forward		$V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$					nA
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	I _{GSSF} /I _{GSSR}	Gate–Body Leakage, Reverse		$V_{GS}=\pm \ 12V \ , V_{DS}=0 \ V$				±100	nA
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	On Char	acteristics (Note 2)	1	Γ		r		1	r
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	V _{GS(th)}	Gate Threshold Voltage	Q1	• • • •		0.6		1.5	V
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $						-0.6		-1.5	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $									mV/°C
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Ű.			$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 0.7 \text{ A}$					mΩ
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$. ,	On–Resistance			SE°C				
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$			02		25°C				
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $			QZ						
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$					25°C		400	700	
	g fs	Forward Transconductance					2.8		S
$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$			-				1.8		
	I _{D(on)}	On–State Drain Current							A
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $			Q2	$V_{GS} = -4.5 V, V_{DS} = -5 V$		-2			
$ \begin{array}{ c c c c c c c c c c c c c c c c c c c$	Dynamic		1			1		1	1
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	C _{iss}	Input Capacitance							pF
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	0		-						
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Coss	Output Capacitance							pF
Q2 V_{DS} =-10 V, V_{GS} = 0 V, f=1.0MHz 9 Switching Characteristics (Note 2) (Note 2) td(on) Turn-On Delay Time Q1 Q2 For Q1: V_{DS} =10 V, I_D = 1 A V_{GS} = 4.5 V, R_{GEN} = 6 Ω 5 10 1 tr Turn-On Rise Time Q1 Q2 For Q2: V_{DS} =10 V, I_D = -1 A V_{GS} = -4.5 V, R_{GEN} = 6 Ω 7 15 1 td(off) Turn-Off Delay Time Q1 Q2 Vos =-10 V, I_D = -1 A V_{GS} = -4.5 V, R_{GEN} = 6 Ω 6 12 tq Turn-Off Fall Time Q1 Q2 For Q1: V_{DS} =10 V, I_D = 0.7 A V_{GS} 9 18 11 Qg Gate-Source Charge Q1 Q1 Q2 For Q1: V_{GS} I_D = 0.7 A V_{GS} 1.1 1.5 7 Qgs Gate-Source Charge Q1 Q2 For Q2: 0.3 0.24 r	<u> </u>	Poverse Transfer Capacitance	-						pF
Switching Characteristics (Note 2) Image: Constraint of the state of	Urss	Reverse Transier Capacitance	-						μr
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Switchin	G Charactoristics	QL				0		
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $			01	504			5	10	ns
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Ld(on)	Turn-On Delay Time							115
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	tr	Turn–On Rise Time						15	ns
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $			Q2				14	25	
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	t _{d(off)}	Turn-Off Delay Time	Q1				9	18	ns
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $				$v_{GS} = -4.5 v, R_{GEN} = 0.22$					
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	t _f	Turn–Off Fall Time							ns
Q2 VDS = 10 V, ID = 0.7 A 1.4 2 Q_{gs} Gate-Source Charge Q1 VGS = 4.5 V, RGEN = 6 Ω 0.24 r Q2 For Q2: 0.3 0.3 0.3 0.3 0.3	Q.	Total Gate Charge		For 01 :					nC
Q_{gs} Gate-Source ChargeQ1 $V_{GS}= 4.5 \text{ V}, R_{GEN} = 6 \Omega$ 0.24rQ2For Q2:0.3	∽g								
Q2 For Q2: 0.3	Q _{gs}	Gate-Source Charge		$V_{GS}\text{=}~4.5~\text{V}, \text{R}_{\text{GEN}}\text{=}~6~\Omega$					nC
	-	-	Q2	For Q2 : V _{DS} =-10 V, I _D = -0.6 A			0.3		
Q_{gd} Gate-Drain Charge Q1 $V_{DS} = -10$ V, $T_{D} = -0.6$ A 0.3 r Q2 $V_{GS} = -4.5$ V, $R_{GEN} = 6 \Omega$ 0.4 0.4	Q _{gd}	Gate–Drain Charge	Q1						nC

			T _A = 25°C unless otherwise noted					
Symbol	Parameter		Test Conditions		Min	Тур	Max	Units
Drain-S	ource Diode Characteris	tics a	nd Maximum Ratings					
	Maximum Continuous Drain–Source Diode Forward Current Q1							
ls	Maximum Continuous Drain-So	ource D	Diode Forward Current	Q1			0.25	А
ls	Maximum Continuous Drain-So	ource E		Q1 Q2			0.25 0.25	A
I _S	Maximum Continuous Drain–So Drain–Source Diode Forward	ource E		Q2		0.74		A

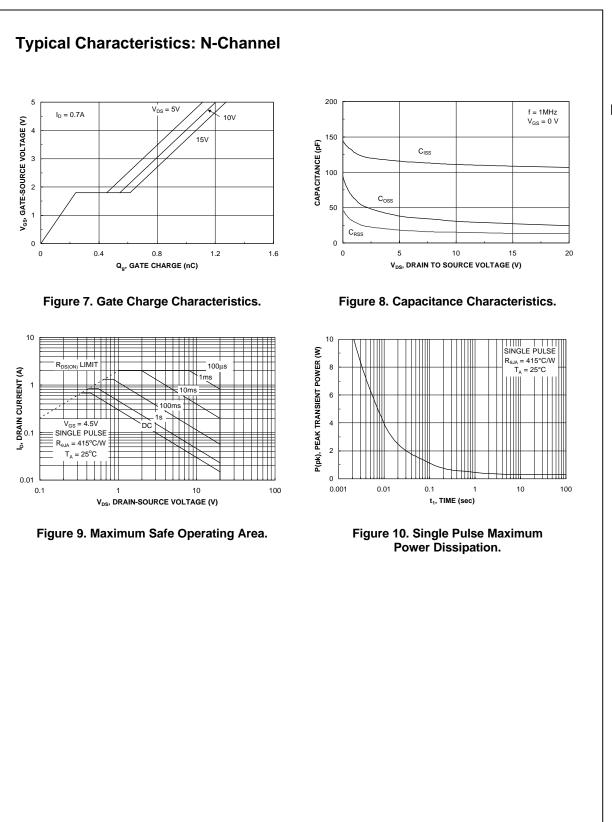
Notes:

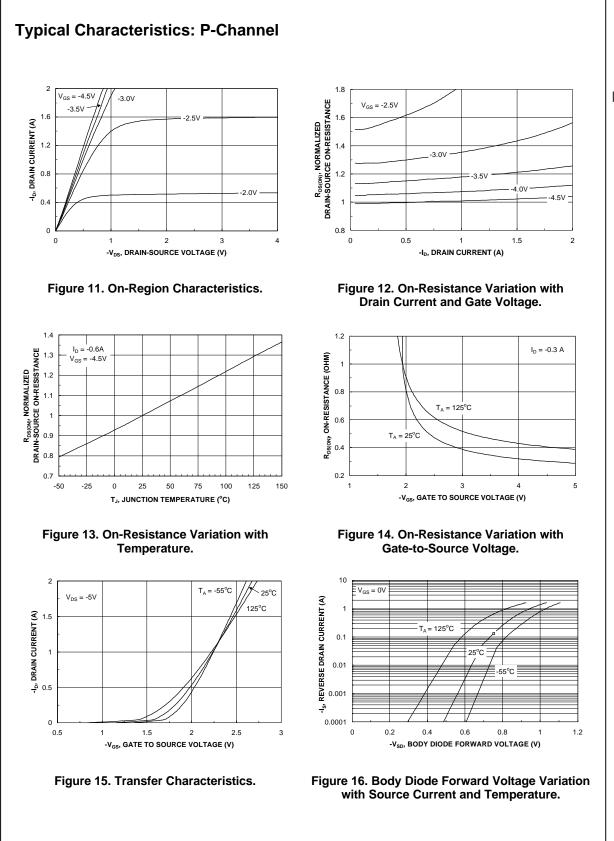
 R_{0JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0JC} is guaranteed by design while R_{0JA} is determined by the user's board design. R_{0JA} = 415°C/W when mounted on a minimum pad of FR-4 PCB in a still air environment.

2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

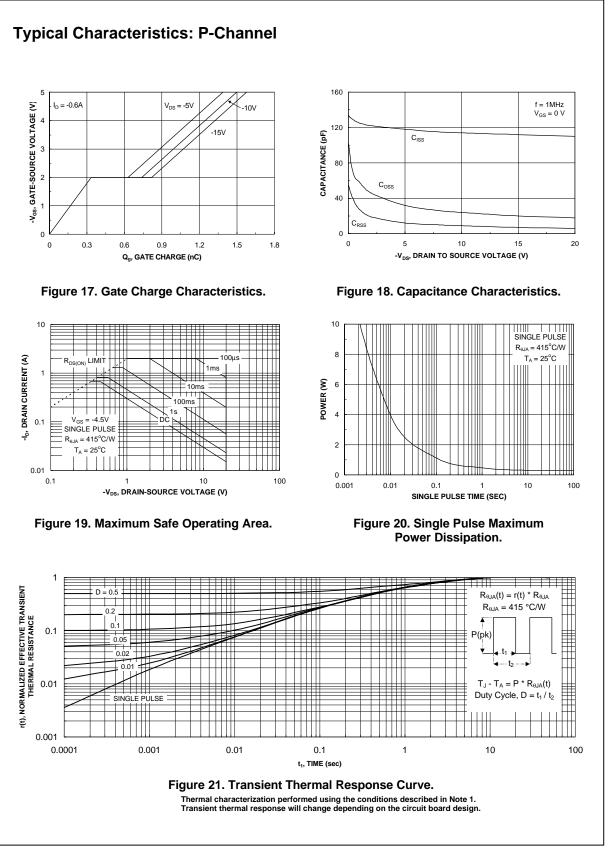


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